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3N128

SILICON N-CHANNEL MOS FIELD-EFFECT TRANSISTOR

... designed for VHF amplifier and oscillator applications in communications equipment.

- High Forward Transadmittance |yfs| = 5000 μmhos (Min) @ f = 1.0 kHz
- Low Input Capacitance —
 C_{iss} = 7.0 pF (Max) @ f = 1.0 MHz
- Low Noise Figure –
 NF = 5.0 dB (Max) @ f = 200 MHz
- High Power Gain —
 PG = 13.5 dB (Min) @ f = 200 MHz
- Complete "y" Parameter Curves
- Third Order Intermodulation Distortion Performance Curve Provided

N-CHANNEL MOS FIELD-EFFECT TRANSISTOR



* MAXIMUM RATINGS

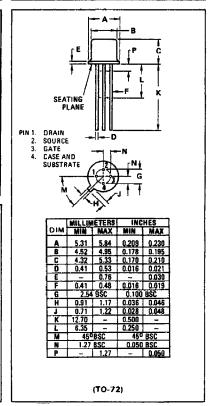
Rating	Symbol	Value	Unit	
Drain-Source Voltage	V _{DS}	+20	Vdc	
Drain-Gate Voltage	V _{DG}	+20	Vdc	
Gate-Source Voltage	VGS	±10	Vdc	
Drain Current	ĭD	50	mAdc	
Power Dissipation ® T _A = 25°C Derate above 25°C	PD	330 2.2	mW mW/ ^Q C	
Operating and Storage Junction Temperature Range	⊤ _J ,T _{stg}	-65 to +175	°C	

*Indicates JEDEC Registered Data.

HANDLING PRECAUTIONS

MOS field-effect transistors have extremely high input resistance. They can be damaged by the accumulation of excess static charge. Avoid possible damage to the devices while handling, testing, or in actual operation, by following the procedures outlined below:

- To avoid the build-up of static charge, the leads of the devices should remain shorted together with a metal ring except when being tested or used.
- 2. Avoid unnecessary handling. Pick up devices by the case instead of the leads.
- Do not insert or remove devices from circuits with the power on because transient voltages may cause permanent damage to the devices.





NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

*ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Gate-Source Breakdown Voltage (1) (I _G = -10 μAdc, V _{DS} = 0)	V(BR)GSS	-50	-	Vdc
Gate-Source Cutoff Voltage (V _{DS} = 15 Vdc, I _D = 50 μAdc)	VGS(off)	-0.5	-8.0	Vdc
Gate Reverse Current $(V_{GS} = -8.0 \text{ Vdc}, V_{DS} = 0)$ $(V_{GS} = -8.0 \text{ Vdc}, V_{DS} = 0, T_{A} = 125^{\circ}\text{C})$	GSS	_	0.05 5.0	nAdc
ON CHARACTERISTICS				
Zero-Gate-Voltage Drain Current (2) (VDS = 15 Vdc, VGS = 0)	DSS	5.0	25	mAdc
SMALL-SIGNAL CHARACTERISTICS				
Forward Transadmittance (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 1.0 kHz)	V _{fs}	5000	12,000	μmhos
Forward Transconductance (V _{DS} = 15 Vdc, i _D = 5.0 mAdc, f = 200 MHz)	Re(yfs)	5000	_	μmhos
Output Conductance (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 200 MHz)	Re(y _{OS})		500	μmhos
Input Conductance (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 200 MHz)	Re(y _{is})	<u> </u>	800	μmhos
Input Capacitance (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 1.0 MHz)	Ciss	_	7.0	pF
Reverse Transfer Capacitance (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 1.0 MHz)	C _{rss}	0.05	0.35	pF
Noise Figure $(V_{DS} = 15 \text{ Vdc}, I_D = 5.0 \text{ mAdc}, f = 200 \text{ MHz})$	NF	=	5.0	dB
Power Gain (V _{DS} = 15 Vdc, I _D = 5.0 mAdc, f = 200 MHz)	PG	13.5	23	dB

*Indicates JEDEC Registered Data.

- (1) Caution Destructive Test, can damage gate oxide beyond operation.
- (2) Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2.0%.

TYPICAL CHARACTERISTICS (TA = 25°C)

